

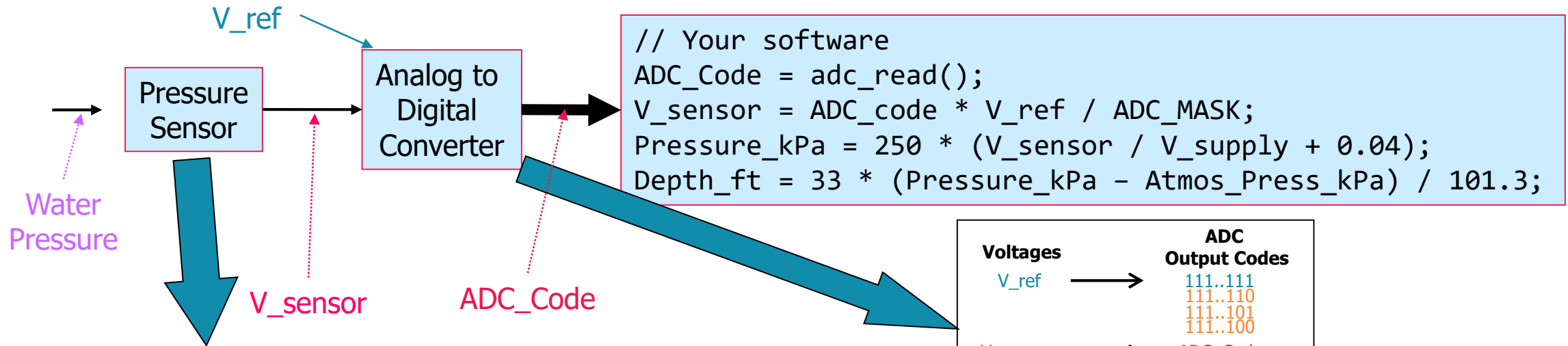
Analog Interfacing

Why It's Needed

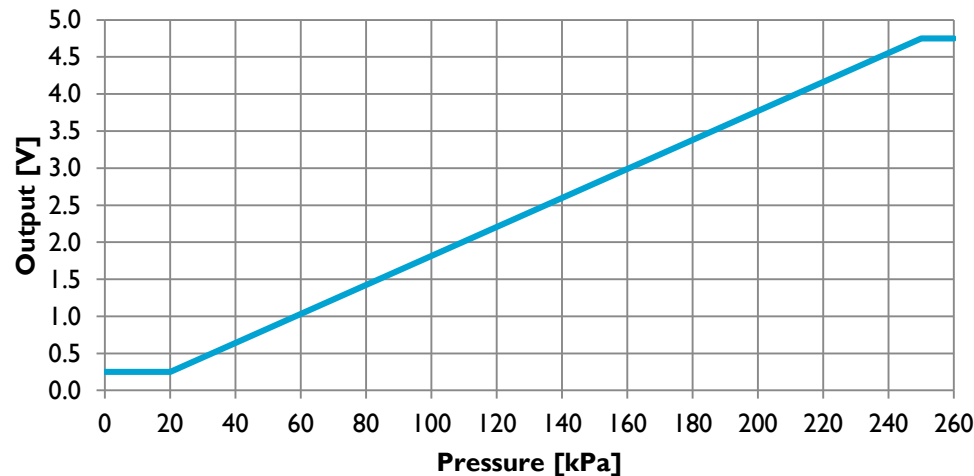
- Embedded systems often need to measure values of physical parameters
- These parameters are usually continuous (analog) and not in a digital form which computers (which operate on discrete data values) can process
- Temperature
 - Thermometer (do you have a fever?)
 - Thermostat for building, fridge, freezer
 - Car engine controller
 - Chemical reaction monitor
 - Safety (e.g. microprocessor processor thermal management)
- Light (or infrared or ultraviolet) intensity
 - Digital camera
 - IR remote control receiver
 - Tanning bed
 - UV monitor
- Rotary position
 - Wind gauge
 - Knobs
- Pressure
 - Blood pressure monitor
 - Altimeter
 - Car engine controller
 - Scuba dive computer
 - Tsunami detector
- Acceleration
 - Air bag controller
 - Vehicle stability
 - Video game remote
- Mechanical strain
- Other
 - Touch screen controller
 - EKG, EEG
 - Breathalyzer

CONVERTING BETWEEN ANALOG AND DIGITAL VALUES

Example Analog Sensor - Depth Gauge



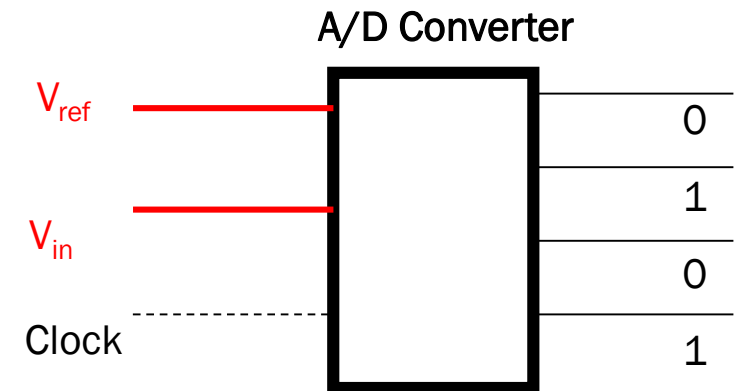
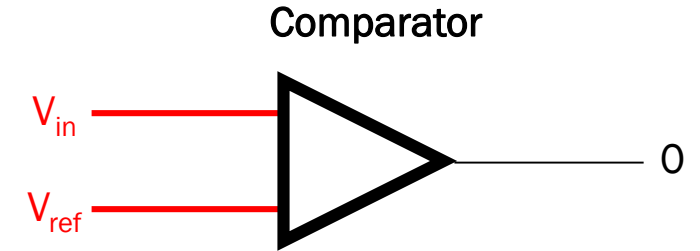
Typical Absolute Pressure vs. Output



- Sensor detects pressure and generates a proportional output voltage V_{sensor}
- ADC generates a proportional digital integer (code) based on V_{sensor} and V_{ref}
- Code can convert that integer to a something more useful
 - first a float representing the voltage,
 - then another float representing pressure,
 - finally another float representing depth

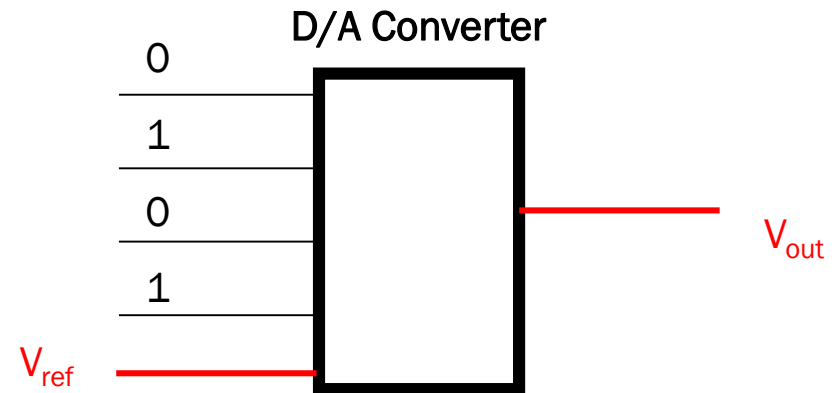
Getting From Analog to Digital

- A Comparator tells us “Is $V_{in} > V_{ref}$?”
 - Compares an analog input voltage with an analog reference voltage and determines which is larger, returning a 1-bit number
 - E.g. Indicate if depth > 100 ft
 - Set V_{ref} to voltage pressure sensor returns with 100 ft depth.
- An Analog to Digital converter [AD or ADC] tells us how large V_{in} is as a fraction of V_{ref} .
 - Reads an analog input signal (usually a voltage) and produces a corresponding multi-bit number at the output.
 - E.g. calculate the depth

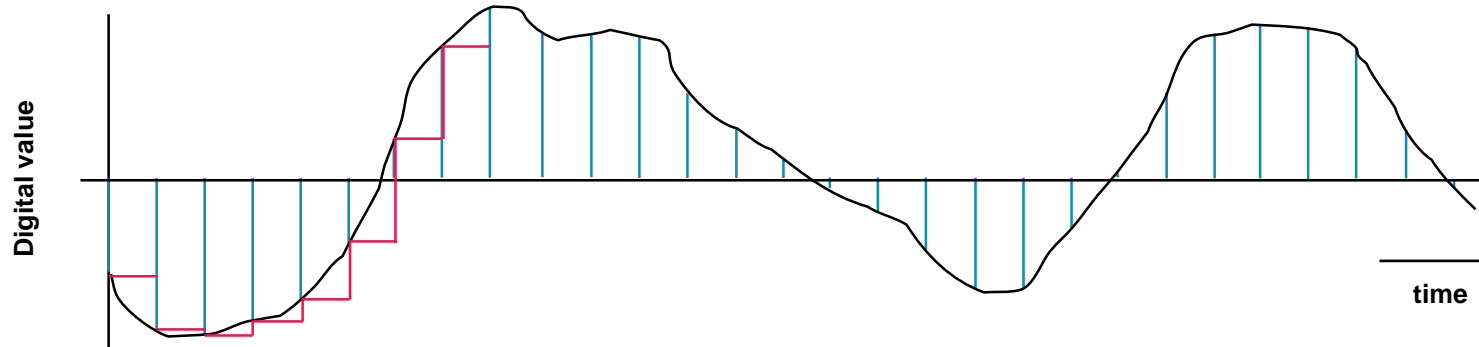


Digital to Analog Conversion

- May need to generate an analog voltage or current as an output signal
 - E.g. audio signal, video signal brightness.
- DAC: “Generate the analog voltage which is this fraction of V_{ref} ”
- Digital to Analog Converter equation
 - n = input code
 - N = number of bits of resolution of converter
 - V_{ref} = reference voltage
 - V_{out} = output voltage. Either
 - $V_{out} = V_{ref} * n / (2N)$ or
 - $V_{out} = V_{ref} * (n+1) / (2N)$
 - The offset +1 term depends on the internal tap configuration of the DAC – check the datasheet to be sure



Waveform Sampling and Quantization



- A waveform is sampled at a constant rate – every Δt
 - Each such sample represents the instantaneous amplitude at the instant of sampling
 - “At 37 ms, the input is 1.91341914513451451234311...V”
 - Sampling converts a continuous time signal to a discrete time signal
- The sample can now be quantized (converted) into a digital value
 - Quantization represents a continuous (analog) value with the closest discrete (digital) value
 - “The sampled input voltage of 1.91341914513451451234311...V is best represented by the code 0x018, since it is in the range of 1.901 to 1.9980V which corresponds to code 0x018.”

Forward Transfer Function Equations

What code n will the ADC use to represent voltage V_{in} ?

General Equation

n = converted code

V_{in} = sampled input voltage

V_{+ref} = upper voltage reference

V_{-ref} = lower voltage reference

N = number of bits of resolution in ADC

$$n = \left\lfloor \frac{V_{in} - V_{-ref}}{V_{+ref} - V_{-ref}} 2^N + 1/2 \right\rfloor$$

Simplification with $V_{-ref} = 0\text{ V}$

$$n = \left\lfloor \frac{V_{in}}{V_{+ref}} 2^N + 1/2 \right\rfloor$$

$$n = \left\lfloor \frac{3.3\text{V}}{5\text{V}} 2^{10} + 1/2 \right\rfloor = 388$$

$\lfloor X \rfloor = \text{floor}(X)$ *floor(X) nearest integer I such that $I \leq X$*
floor($x+0.5$) rounds x to the nearest integer

Inverse Transfer Function

What range of voltages V_{in_min} to V_{in_max} does code n represent?

General Equation

n = converted code

V_{in_min} = minimum input voltage for code n

V_{in_max} = maximum input voltage for code n

V_{+ref} = upper voltage reference

V_{-ref} = lower voltage reference

N = number of bits of resolution in ADC

$$V_{in_min} = \frac{n - \frac{1}{2}}{2^N} (V_{+ref} - V_{-ref}) + V_{-ref}$$

$$V_{in_max} = \frac{n + \frac{1}{2}}{2^N} (V_{+ref} - V_{-ref}) + V_{-ref}$$

Simplification with $V_{-ref} = 0\text{ V}$

$$V_{in_min} = \frac{n - \frac{1}{2}}{2^N} (V_{+ref})$$

$$V_{in_max} = \frac{n + \frac{1}{2}}{2^N} (V_{+ref})$$

What if the Reference Voltage is not known?

- Example - running off an unregulated battery (to save power)
- Measure a known voltage and an unknown voltage

$$V_{unknown} = V_{known} \frac{n_{unknown}}{n_{known}}$$

- Many MCUs include an internal fixed voltage source which ADC can measure for this purpose
- Can also solve for Vref

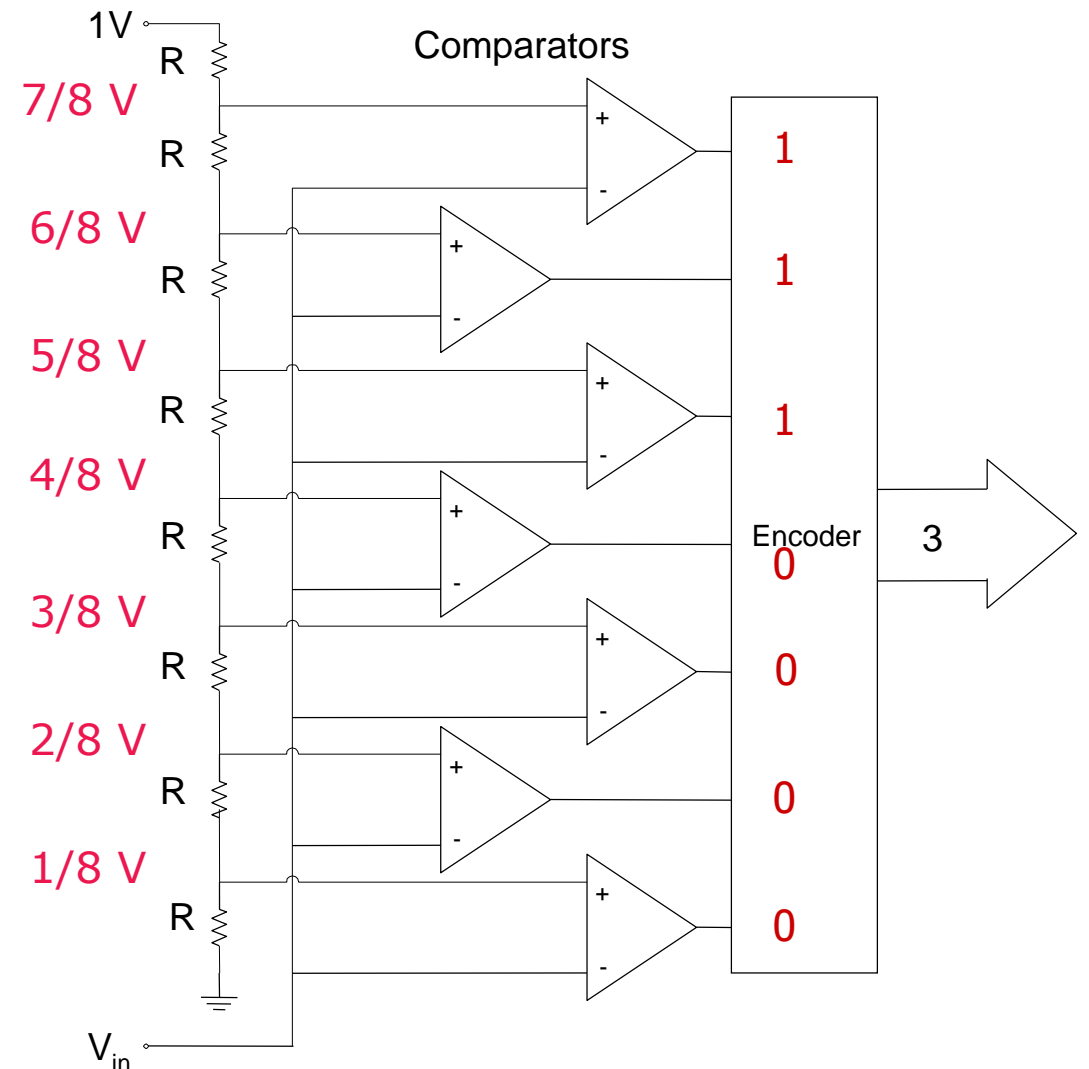
$$V_{ref} = V_{known} \frac{2^N}{n}$$

“My ADC tells me that channel 27 returns a code of 0x6543, so I can calculate that $V_{REFSH} = 1.0V * 2^{16}/0x6543 = \dots$ ”

ANALOG TO DIGITAL CONVERSION CONCEPTS

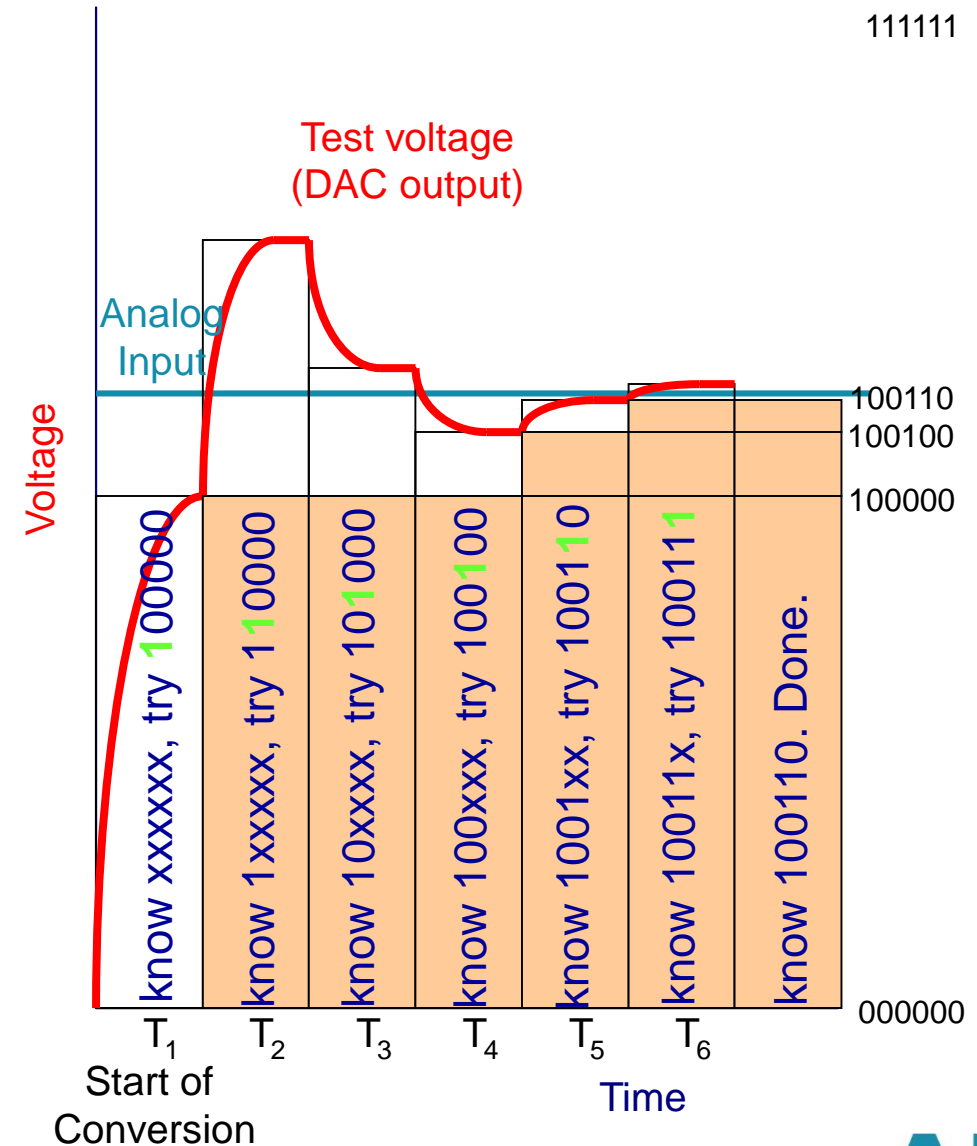
A/D – Flash Conversion

- A multi-level voltage divider is used to set voltage levels over the complete range of conversion.
- A comparator is used at each level to determine whether the voltage is lower or higher than the level.
- The series of comparator outputs are encoded to a binary number in digital logic (a priority encoder)
- Components used
 - $2N$ resistors
 - $2N-1$ comparators
- Note
 - This particular resistor divider generates voltages which are not offset by $\frac{1}{2}$ bit, so maximum error is 1 bit
 - We could change this offset voltage by using resistors of values $R, 2R, 2R \dots 2R, 3R$ (starting at bottom)



ADC - Successive Approximation Conversion

- Successively approximate input voltage by using a binary search and a DAC
- SA Register holds current approximation of result
- Set all DAC input bits to 0
- Start with DAC's most significant bit
- Repeat
 - Set next input bit for DAC to 1
 - Wait for DAC and comparator to stabilize
 - If the DAC output (test voltage) is smaller than the input then set the current bit to 1, else clear the current bit to 0



ADC Performance Metrics

- Linearity measures how well the transition voltages lie on a straight line.
- Differential linearity measure the equality of the step size.
- Conversion time: between start of conversion and generation of result
- Conversion rate = inverse of conversion time

Sampling Problems

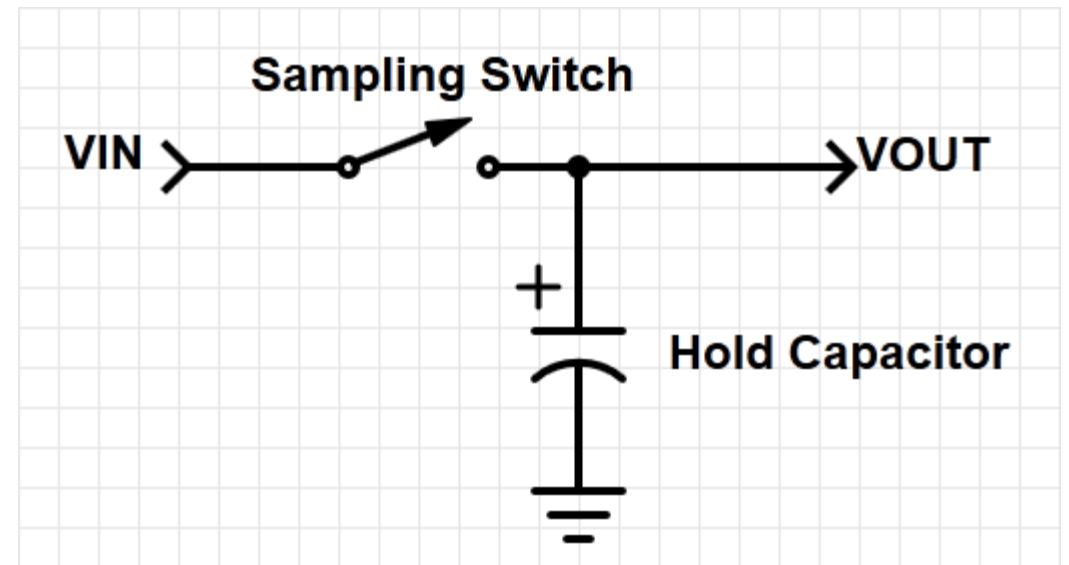
- Nyquist criterion
 - $F_{\text{sample}} \geq 2 * F_{\text{max}}$ frequency component
 - Frequency components above $\frac{1}{2} F_{\text{sample}}$ are aliased, distort measured signal
- Nyquist and the real world
 - This theorem assumes we have a perfect filter with “brick wall” roll-off
 - Real world filters have more gentle roll-off
 - Inexpensive filters are even worse (e.g. first order filter is 20 dB/decade, aka 6 dB/octave)
 - So we have to choose a sampling frequency high enough that our filter attenuates aliasing components adequately

Inputs

- Differential
 - Use two channels, and compute difference between them
 - Very good noise immunity
 - Some sensors offer differential outputs (e.g. Wheatstone Bridge)
- Multiplexing
 - Typically share a single ADC among multiple inputs
 - Need to select an input, allow time to settle before sampling
- Signal Conditioning
 - Amplify and filter input signal
 - Protect against out-of-range inputs with clamping diodes

Sample and Hold Devices

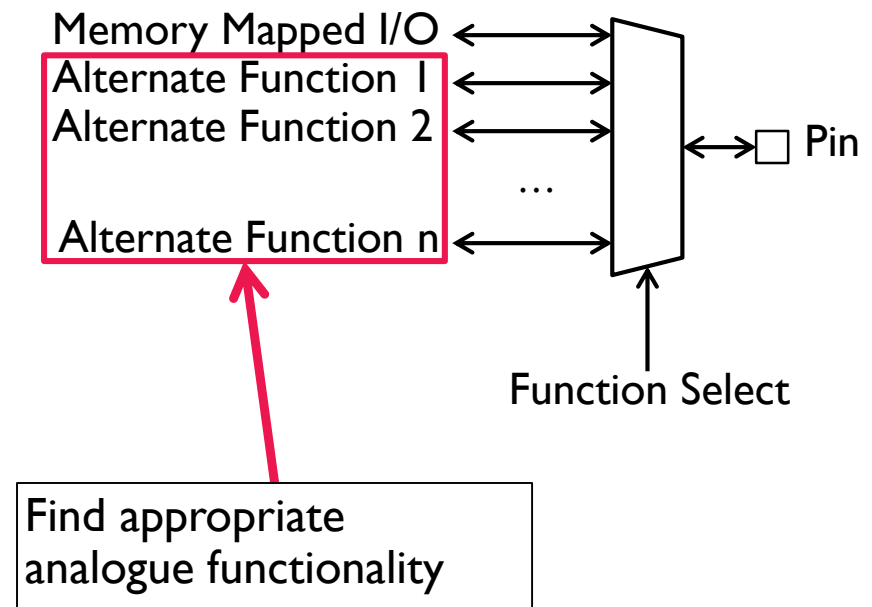
- Some A/D converters require the input analog signal to be held constant during conversion, (e.g. successive approximation devices)
- In other cases, peak capture or sampling at a specific point in time necessitates a sampling device.
- This function is accomplished by a sample and hold device as shown to the right
- These devices are incorporated into some A/D converters



ANALOG INTERFACING PERIPHERALS

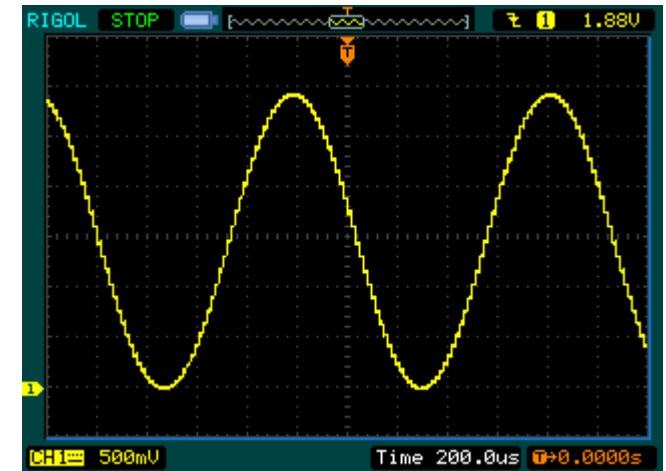
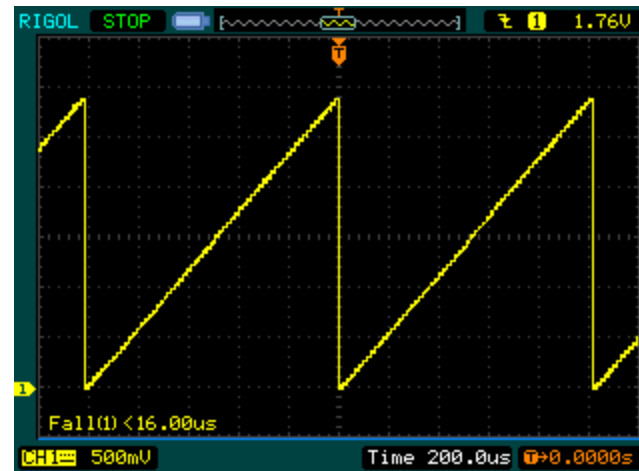
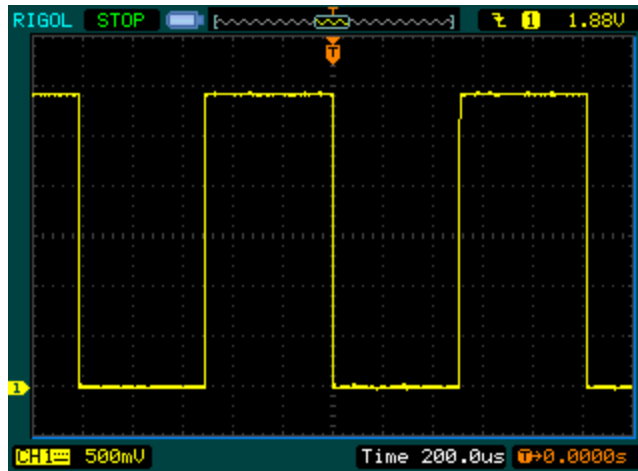
GPIO Alternative Functions

- Pins may have different features
- To enable an alternative function, set up the appropriate register
- May also have analogue paths for ADC / DAC etc.
- Advantages:
 - Saves space on the package
 - Improves flexibility



DIGITAL TO ANALOG CONVERTER

Example: Waveform Generation



- DAC can be used to generate arbitrary waveforms
 - Pregenerate lookup table
 - Update DAC output value
 - Delay
 - Repeat

C Code – Initialisation

```
void tone_init(void) {
    dac_init();
    sinewave_init();
}

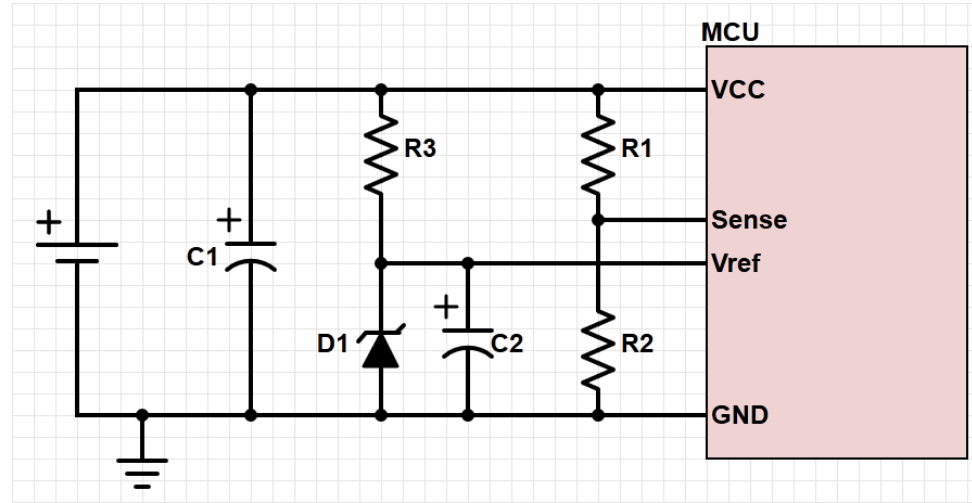
void sinewave_init(void) {
    int n;
    for (n = 0; n < NUM_STEPS; n++) {
        sine_table[n] = MAX_DAC_CODE * (1 + sin(n*2*PI/NUM_STEPS)) / 2;
    }
}
```

C Code – Playback

```
void tone_play(int period_us, int num_cycles, wavetype wave) {
    int sample, step;
    while(num_cycles-- > 0) {
        for (step = 0; step < NUM_STEPS; step++) {
            switch(wave) {
                case SINE: sample = sine_table[step]; break;
                case SQUARE: sample = step < NUM_STEPS / 2 ? 0 : MAX_DAC_CODE;
                    break;
                case RAMP: sample = (step * MAX_DAC_CODE) / NUM_STEPS; break;
            }
            dac_set(sample);
            delay_us(period_us);
        }
    }
}
```

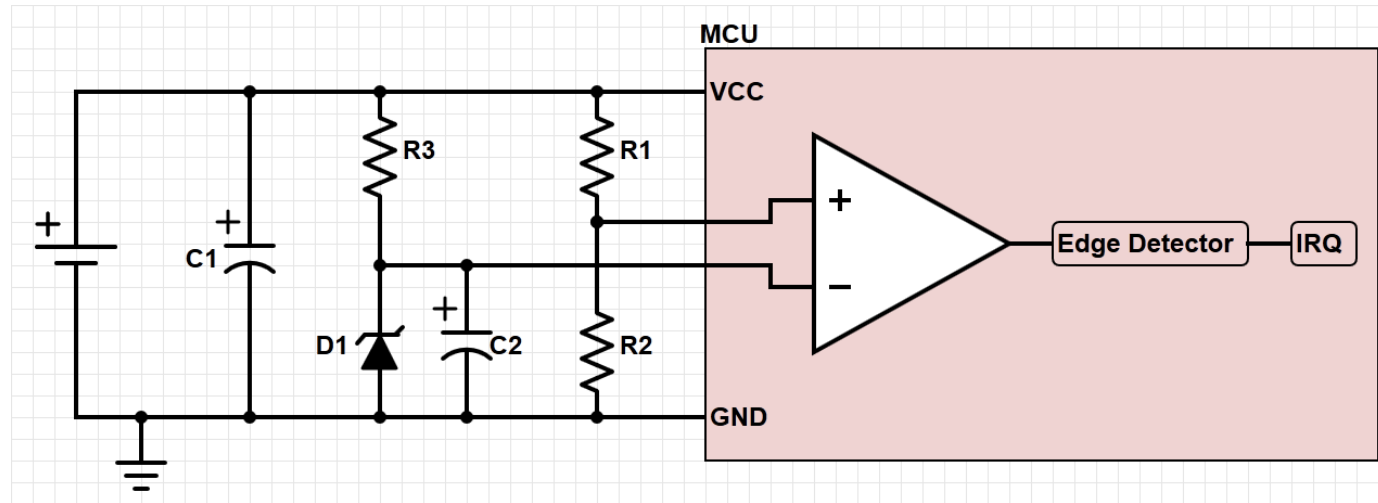
ANALOG COMPARATOR

Example: Power Failure Detection



- Need warning of when power has failed
 - Very limited amount of time before capacitor C1 discharges
 - Save critical information
 - Turn off output devices
 - Put system into safe mode
- Can use a comparator to compare V_{CC} against a fixed reference voltage V_{ref}

Comparator Overview



- Comparator compares Sense and Vref
- Comparator output indicates if $\text{Sense} > \text{Vref}$ (1) or $\text{Sense} < \text{Vref}$ (0)
- Can generate an interrupt request (+, -, or +- edges)
- If the Sense input drops below Vref, fire an interrupt

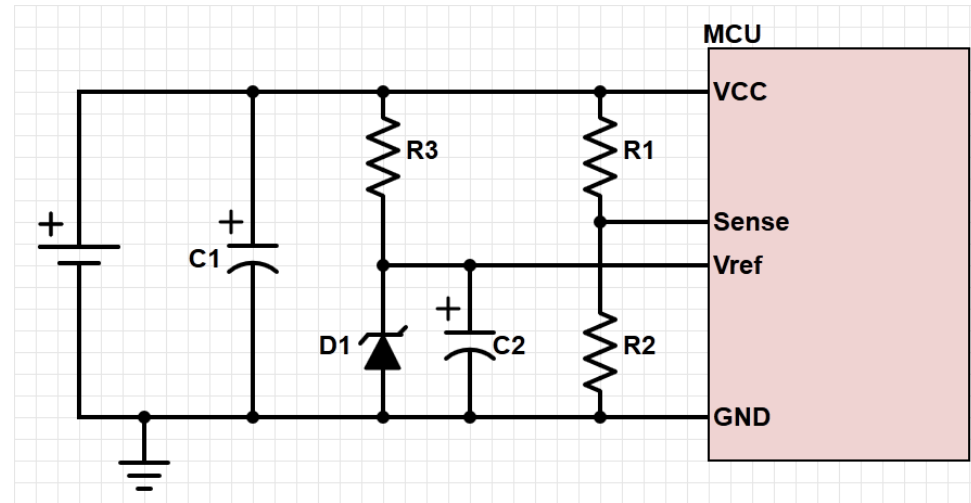
C Code – Comparator

```
void comparator_isr(int state) {
    if (state) {
        // Sense > Vref, turn off LEDs.
        leds_set(0, 0, 0);
    } else {
        // Sense < Vref, turn on red LED.
        leds_set(1, 0, 0);
    }
}

int main(void) {
    comparator_init();
    comparator_set_trigger(CompBoth); // ISR on both rising and falling edges.
    comparator_set_callback(comparator_isr);
    ...
}
```

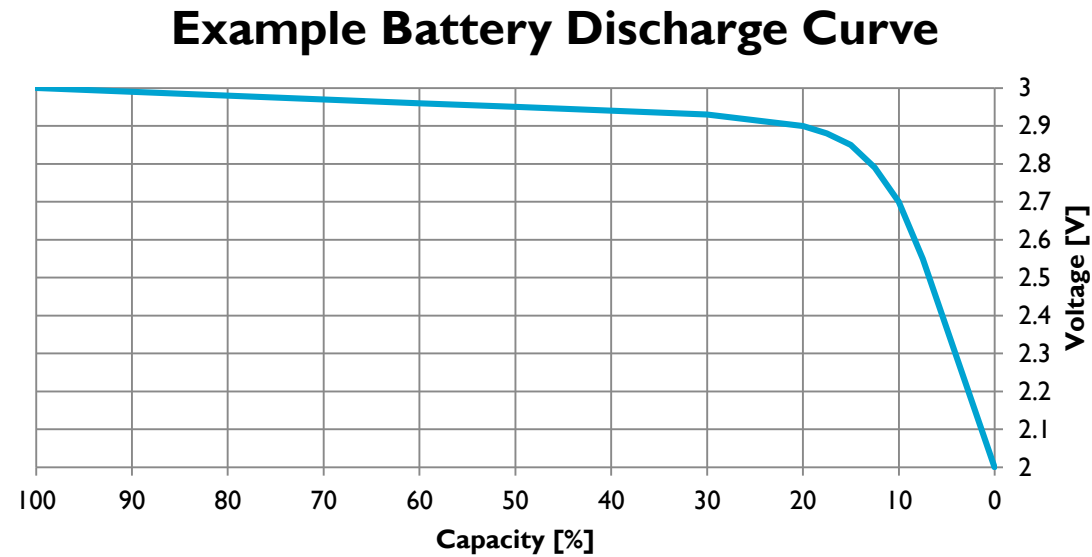
ANALOG TO DIGITAL CONVERTER

Example: Battery Monitoring



- Operates similar to comparator based system
- Measures battery voltage, better indication of battery life than comparator
- Can provide information about battery discharge rate

Battery Discharge



- As the battery discharges, the voltage decreases
- Measure with respect to V_{ref} (fixed voltage reference)
- Convert to capacity with look-up table and interpolation